

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/729,405 | Applicant(s)/Patent Under Reexamination TERZIOGLU ET AL. | |
| | Examiner Viet Q. Nguyen | Art Unit 2827 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-5,787,046 | 07-1998 | Furuyama et al | 365/230.03 |
| | B | US-5,841,712 | 11-1998 | Wendell et al | 365/200 |
| | C | US-5,243,570 | 09-1993 | Sarawatari | 365/201 |
| | D | US-5,349,558 | 09-1994 | Cleveland et al | 365/200 |
| | E | US-5,669,306 | 12-1997 | Lee et al | 365/200 |
| | F | US-5,889,725 | 03-1999 | Aikawa et al | 365/230.06 |
| | G | US-5,953,267 | 09-1999 | Young Oh | 365/200 |
| | H | US-5,959,907 | 09-1999 | Kim et al | 365/200 |
| | I | US-5,642,316 | 06-1997 | Tran et al | 365/200 |
| | J | US-6,100,748 | 08-2000 | Oh Young | 357/526 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------|----------------|
| * | N | JP402021490A | 01-1990 | Japan | Uehara | G11C 11/406 |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.